- Single-Chip and Single-Supply Interface for Two IBM ${ }^{\text {™ }}$ PC/AT Serial Ports
- Meet or Exceed the Requirements of TIA/EIA-232-F and ITU v. 28 Standards
- Operate With $3-\mathrm{V}$ to $5.5-\mathrm{V} \mathrm{V}_{\mathrm{CC}}$ Supply
- Always-Active Noninverting Receiver Output (쥬OUT2) Per Port
- Operate Up To 250 kbit/s
- Low Standby Current ... $1 \mu \mathrm{~A}$ Typical
- External Capacitors . . . $4 \times 0.22 \mu \mathrm{~F}$
- Accept 5-V Logic Input With 3.3-V Supply
- Allow for Flexible Power Down of Either Serial Port
- Serial-Mouse Driveability
- RS-232 Bus-Pin ESD Protection Exceeds $\pm 15$ kV Using Human-Body Model (HBM)
- Applications
- Battery-Powered Systems, Notebooks, Laptops, Palmtop PCs, and Hand-Held Equipment


## description/ordering information

The SN65C23243 and SN75C23243 consist of two ports, each containing three line drivers and five line receivers, and a dual charge-pump circuit with $\pm 15$-kV ESD protection pin to pin (serial-port connection pins, including GND). These devices meet the requirements of TIA/EIA-232-F and provide the electrical interface between an asynchronous communication controller and the serial-port connector. This combination of drivers and receivers matches that needed for two typical serial ports used in an IBM PC/AT, or compatible. The charge pump and four small external capacitors allow operation from a single $3-\mathrm{V}$ to $5.5-\mathrm{V}$ supply. In addition, these devices include an always-active noninverting output ( $\overline{\mathrm{ROUT} 2}$ ) per port, which allows applications using the ring indicator to transmit data while the devices are powered down. The devices operate at data signaling rates up to $250 \mathrm{kbit} / \mathrm{s}$ and a maximum of $30-\mathrm{V} / \mu \mathrm{s}$ driver output slew-rate.

ORDERING INFORMATION

| $\mathrm{T}_{\mathbf{A}}$ | PACKAGE $\dagger$ |  | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
| :---: | :---: | :---: | :---: | :---: |
| $-0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$ | SSOP (DL) | Tube of 25 | SN75C23243DL | 75C23243 |
|  |  | Reel of 1000 | SN75C23243DLR |  |
|  | TSSOP (DGG) | Reel of 2000 | SN75C23243DGGR | 75C23243 |
| $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | SSOP (DL) | Tube of 25 | SN65C23243DL | 65C23243 |
|  |  | Reel of 1000 | SN65C23243DLR |  |
|  | TSSOP (DGG) | Reel of 2000 | SN65C23243DGGR | 65C23243 |

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

## description/ordering information (continued)

Flexible control options for power management are available when either or both serial ports are inactive. The auto-powerdown feature functions when FORCEON is low and FORCEOFF is high. During this mode of operation, if the device does not sense a valid RS-232 signal, the driver outputs of its respective port are disabled. If $\overline{\text { FORCEOFF }}$ is set low, both drivers and receivers (except $\overline{\text { ROUT2 }}$ ) are shut off, and the supply current is reduced to $1 \mu \mathrm{~A}$. Disconnecting the serial port or turning off the peripheral drivers causes the auto-powerdown condition to occur.

Auto-powerdown can be disabled when FORCEON and FORCEOFF are high and should be done when driving a serial mouse. With auto-powerdown enabled, the RS-232 port is activated automatically when a valid signal is applied to any respective receiver input. The INV output is used to notify the user if an RS-232 signal is present at any receiver input. $\overline{\mathrm{INV}}$ is high (valid data) if any receiver input voltage is greater than 2.7 V or less than -2.7 V or has been between -0.3 V and 0.3 V for less than $30 \mu \mathrm{~s}$. $\overline{\mathrm{IVV}}$ is low (invalid data) if all receiver input voltages are between -0.3 V and 0.3 V for more than $30 \mu \mathrm{~s}$. Refer to Figure 5 for receiver input levels.

## Function Tables

EACH DRIVER
(each port)

| INPUTS |  |  |  | OUTPUT DOUT | DRIVER STATUS |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DIN | FORCEON | FORCEOFF | $\begin{gathered} \hline \text { VALID RIN } \\ \text { RS-232 LEVEL } \end{gathered}$ |  |  |
| X | X | L | X | Z | Powered off |
| L | H | H | X | H | Normal operation with |
| H | H | H | X | L | auto-powerdown disabled |
| L | L | H | Yes | H | Normal operation with |
| H | L | H | Yes | L | auto-powerdown enabled |
| L | L | H | No | Z | Powered off by |
| H | L | H | No | Z | auto-powerdown feature |

$H=$ high level, $L=$ low level, $X=$ irrelevant, $Z=$ high impedance
EACH RECEIVER
(each port)

| INPUTS |  |  |  | OUTPUTS |  | RECEIVER STATUS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| RIN2 | $\begin{gathered} \text { RIN1, } \\ \text { RIN3-RIN5 } \end{gathered}$ | FORCEOFF | $\begin{gathered} \hline \text { VALID RIN } \\ \text { RS-232 LEVEL } \end{gathered}$ | $\overline{\text { ROUT2 }}$ | ROUT |  |
| L | X | L | X | L | Z | Powered off while |
| H | X | L | X | H | Z | ROUT2 is active |
| L | L | H | Yes | L | H |  |
| L | H | H | Yes | L | L | Normal operation with |
| H | L | H | Yes | H | H | auto-powerdown |
| H | H | H | Yes | H | L | disabled/enabled |
| Open | Open | H | No | L | H |  |

$\mathrm{H}=$ high level, $\mathrm{L}=$ low level, $\mathrm{X}=$ irrelevant, $\mathrm{Z}=$ high impedance (off), Open = input disconnected or connected driver off

## logic diagram (positive logic)



## timing

Figure 1 shows how the two independent serial ports can be enabled or disabled. As shown by the logic states, depending on the FORCEOFF, FORCEON, and receiver input levels, either port can be powered down. Intermediate receiver input levels indicate a $0-\mathrm{V}$ input. Also, it is assumed a pulldown resistor to ground is used for the receiver outputs. The INV pin goes low when its respective receiver input does not supply a valid RS-232 level. For simplicity, voltage levels, timing differences, and input/output edge rates are not shown.


NOTES: A. Ports $A$ and $B$ manually powered off
B. Port A manually powered off, port $B$ in normal operation with auto-powerdown enabled
C. Port B powered off by auto-powerdown, port A in normal operation with auto-powerdown enabled
D. Port A in normal operation with auto-powerdown disabled, port B manually powered off
E. Ports $A$ and $B$ in normal operation with auto-powerdown disabled

Figure 1. Timing Diagram

# SN65C23243, SN75C23243 3-V TO 5.5-V DUAL RS-232 PORT 

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$

Supply voltage range, $\mathrm{V}_{\mathrm{CC}}$ (see Note 1) ........................................................ -0.3 V to 6 V
Positive output supply voltage range, $\mathrm{V}+$ (see Note 1) .......................................... 0.3 V to 7 V


Input voltage range, $\mathrm{V}_{\text {I }}$ : Driver (FORCEOFF, FORCEON) . ...................................... 0.3 V to 6 V
Receiver ............................................................... 25 V to 25 V
 Receiver ( $\overline{\mathrm{INV}})$............................................. 0.3 V to $\mathrm{V}_{\mathrm{CC}}+0.3 \mathrm{~V}$
Package thermal impedance, $\theta_{\mathrm{JA}}$ (see Notes 2 and 3): DGG package ............................. $70^{\circ} \mathrm{C} / \mathrm{W}$
DL package .................................. $63^{\circ} \mathrm{C} / \mathrm{W}$


$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTES: 1. All voltages are with respect to network GND
2. Maximum power dissipation is a function of $T_{J}(\max ), \theta_{J A}$, and $T_{A}$. The maximum allowable power dissipation at any allowable ambient temperature is $\mathrm{P}_{\mathrm{D}}=\left(\mathrm{T}_{\mathrm{J}}(\max )-\mathrm{T}_{\mathrm{A}}\right) / \theta_{\mathrm{JA}}$. Operating at the absolute maximum $\mathrm{T}_{\mathrm{J}}$ of $150^{\circ} \mathrm{C}$ can affect reliability.
3. The package thermal impedance is calculated in accordance with JESD 51-7.
recommended operating conditions (see Note 4 and Figure 7)


NOTE 4: Test conditions are $\mathrm{C} 1-\mathrm{C} 4=0.22 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V} ; \mathrm{C} 1=0.047 \mu \mathrm{~F}, \mathrm{C} 2-\mathrm{C} 4=0.33 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V} \pm 0.5 \mathrm{~V}$.
electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 7)

| PARAMETER |  |  | TEST CONDITIONS | MIN | TYPキ | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | Input leakage current | FORCEOFF, FORCEON |  |  | $\pm 0.01$ | $\pm 1$ | $\mu \mathrm{A}$ |
| ICC | Supply current$\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right)$ | Auto-powerdown disabled | $\begin{array}{\|l} \hline \text { No load, } \\ \text { FORCEOFF and FORCEON at } \mathrm{V}_{\mathrm{CC}} \\ \hline \end{array}$ |  | 0.6 | 2 | mA |
|  |  | Powered off | No load, $\overline{\text { FORCEOFF }}$ at GND |  | 1 | 20 | $\mu \mathrm{A}$ |
|  |  | Auto-powerdown enabled | No load, $\overline{\text { FORCEOFF }}$ at $\mathrm{V}_{\mathrm{CC}}$, FORCEON at GND, <br> All RIN are open or grounded |  | 1 | 20 |  |

[^0]
## DRIVER SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 7)

|  | PARAMETER | TEST CONDITIONS |  | MIN | TYP† | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OH}}$ | High-level output voltage | All DOUT at $\mathrm{R}_{\mathrm{L}}=3 \mathrm{k} \Omega$ to GND |  | 5 | 5.4 |  | V |
| VOL | Low-level output voltage | All DOUT at $\mathrm{R}_{\mathrm{L}}=3 \mathrm{k} \Omega$ to GND |  | -5 | -5.4 |  | V |
| $\mathrm{V}_{\mathrm{O}}$ | Output voltage (mouse driveability) | $\begin{aligned} & \text { DIN1 }=\text { DIN2 }=\text { GND, DIN3 }=\text { VCC }, \\ & 3-\mathrm{k} \Omega \text { to GND at DOUT3, DOUT1 }=\text { DOUT2 }=-2.5 \mathrm{~mA} \end{aligned}$ |  | $\pm 5$ |  |  | V |
| IIH | High-level input current | $\mathrm{V}_{1}=\mathrm{V}_{\text {CC }}$ |  |  | $\pm 0.01$ | $\pm 1$ | $\mu \mathrm{A}$ |
| IIL | Low-level input current | $\mathrm{V}_{1}$ at GND |  |  | $\pm 0.01$ | $\pm 1$ | $\mu \mathrm{A}$ |
| Ios | Short-circuit output current $\ddagger$ | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=0 \mathrm{~V}$ | $\pm 35$ |  | $\pm 60$ | mA |
|  |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=0 \mathrm{~V}$ |  |  |  |  |
| $r_{0}$ | Output resistance | $\mathrm{V}_{\mathrm{CC}}, \mathrm{V}+$, and $\mathrm{V}-=0 \mathrm{~V}, \quad \mathrm{~V}_{\mathrm{O}}= \pm 2 \mathrm{~V}$ |  | 300 | 10M |  | $\Omega$ |
|  | Output leakage current | $\overline{\text { FORCEOFF }}=$ GND | $\mathrm{V}_{\mathrm{O}}= \pm 12 \mathrm{~V}, \quad \mathrm{~V}_{\mathrm{CC}}=3 \mathrm{~V}$ to 3.6 V |  |  | $\pm 25$ | $\mu \mathrm{A}$ |
|  |  |  | $\mathrm{V}_{\mathrm{O}}= \pm 10 \mathrm{~V}, \quad \mathrm{~V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ to 5.5 V |  |  | $\pm 25$ |  |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ Short-circuit durations should be controlled to prevent exceeding the device absolute power dissipation ratings, and not more than one output should be shorted at a time.
NOTE 4: Test conditions are $\mathrm{C} 1-\mathrm{C} 4=0.22 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V} ; \mathrm{C} 1=0.047 \mu \mathrm{~F}, \mathrm{C} 2-\mathrm{C} 4=0.33 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V} \pm 0.5 \mathrm{~V}$.
switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 7)

|  | PARAMETER | TEST CONDITIONS |  | MIN | TYP $\dagger$ | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Maximum data rate | $C_{L}=1000 \mathrm{pF},$ One DOUT switching, | $\mathrm{R}_{\mathrm{L}}=3 \mathrm{k} \Omega,$ <br> See Figure 1 | 250 |  |  | kbit/s |
| $\mathrm{t}_{\text {sk }}(\mathrm{p})$ | Pulse skew§ | $\mathrm{C}_{\mathrm{L}}=150 \mathrm{pF}$ to 2500 pF | $\mathrm{R}_{\mathrm{L}}=3 \mathrm{k} \Omega \text { to } 7 \mathrm{k} \Omega \text {, }$ <br> See Figure 2 |  | 100 |  | ns |
| SR(tr) | Slew rate, transition region (see Figure 1) | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \\ & \mathrm{R}_{\mathrm{L}}=3 \mathrm{k} \Omega \text { to } 7 \mathrm{k} \Omega \end{aligned}$ | $\mathrm{C}_{\mathrm{L}}=150 \mathrm{pF}$ to 1000 pF | 6 |  | 30 | V/us |
|  |  |  | $C_{L}=150 \mathrm{pF}$ to 2500 pF | 4 |  | 30 |  |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
§ Pulse skew is defined as |tPLH - tpHL| of each channel of the same device.
NOTE 4: Test conditions are $\mathrm{C} 1-\mathrm{C} 4=0.22 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V} ; \mathrm{C} 1=0.047 \mu \mathrm{~F}, \mathrm{C} 2-\mathrm{C} 4=0.33 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V} \pm 0.5 \mathrm{~V}$.

## RECEIVER SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 7)

|  | PARAMETER | TEST CONDITIONS | MIN | TYP $\dagger$ | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OH}}$ | High-level output voltage | $\mathrm{IOH}=-1 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{CC}}-0.6 \mathrm{~V}$ | $\mathrm{V}_{\mathrm{CC}}-0.1 \mathrm{~V}$ |  | V |
| $\mathrm{V}_{\mathrm{OL}}$ | Low-level output voltage | $\mathrm{IOL}=1.6 \mathrm{~mA}$ |  |  | 0.4 | V |
| $\mathrm{V}_{\text {IT }+}$ | Positive-going input threshold voltage | $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ |  | 1.6 | 2.4 | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ |  | 1.9 | 2.4 |  |
| $V_{\text {IT- }}$ | Negative-going input threshold voltage | $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ | 0.6 | 1.1 |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ | 0.8 | 1.4 |  |  |
| Vhys | Input hysteresis ( $\mathrm{V}_{\text {IT+}}$ - $\mathrm{V}_{\text {IT-}}$ ) |  |  | 0.5 |  | V |
| $\mathrm{I}_{\text {off }}$ | Output leakage current (except ROUT2B) | FORCEOFF $=0 \mathrm{~V}$ |  | $\pm 0.05$ | $\pm 10$ | $\mu \mathrm{A}$ |
| $\mathrm{r}_{\mathrm{i}}$ | Input resistance | $\mathrm{V}_{\mathrm{I}}= \pm 3 \mathrm{~V}$ to $\pm 25 \mathrm{~V}$ | 3 | 5 | 7 | $\mathrm{k} \Omega$ |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
NOTE 4: Test conditions are C1-C4 $=0.22 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V} ; \mathrm{C} 1=0.047 \mu \mathrm{~F}, \mathrm{C} 2-\mathrm{C} 4=0.33 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V} \pm 0.5 \mathrm{~V}$.
switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 7)

|  | PARAMETER | TEST CONDITIONS | MIN | TYP $\dagger$ |
| :--- | :--- | :--- | ---: | :---: |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ Pulse skew is defined as |tpLH - tpHLl of each channel of the same device.
NOTE 4: Test conditions are $\mathrm{C} 1-\mathrm{C} 4=0.22 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V} ; \mathrm{C} 1=0.047 \mu \mathrm{~F}, \mathrm{C} 2-\mathrm{C} 4=0.33 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V} \pm 0.5 \mathrm{~V}$.

## AUTO-POWERDOWN SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 6)

|  | PARAMETER | TEST CONDITIONS | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{T}+\text { (valid) }}$ | Receiver input threshold for INV high-level output voltage | $\begin{aligned} & \text { FORCEON }=\text { GND, } \\ & \text { FORCEOFF }=\mathrm{V}_{\mathrm{CC}} \end{aligned}$ |  | 2.7 | V |
| $\mathrm{V}_{\mathrm{T} \text {-(valid) }}$ | Receiver input threshold for $\overline{\mathrm{INV}}$ high-level output voltage | $\begin{aligned} & \text { FORCEON }=\text { GND, } \\ & \hline \text { FORCEOFF }=V_{C C} \end{aligned}$ | -2.7 |  | V |
| $\mathrm{V}_{\mathrm{T} \text { (invalid) }}$ | Receiver input threshold for $\overline{\mathrm{NV}}$ low-level output voltage | $\begin{aligned} & \text { FORCEON }=\text { GND, } \\ & \text { FORCEOFF }=\mathrm{V}_{\mathrm{CC}} \end{aligned}$ | -0.3 | 0.3 | V |
| VOH | $\overline{\text { INV }}$ high-level output voltage | $\begin{aligned} & \mathrm{I} \text { OH }=-1 \mathrm{~mA}, \text { FORCEON }=\text { GND, } \\ & \text { FORCEOFF }=\mathrm{V}_{\mathrm{CC}} \end{aligned}$ | $\mathrm{V}_{\mathrm{CC}}-0.6$ |  | V |
| $\mathrm{V}_{\mathrm{OL}}$ | $\overline{\text { INV }}$ low-level output voltage | $\begin{aligned} & \frac{\mathrm{l}}{\mathrm{OL}}=1.6 \mathrm{~mA}, \text { FORCEON }=\mathrm{GND}, \\ & \mathrm{FORCEOFF}=\mathrm{V} C \mathrm{C} \end{aligned}$ |  | 0.4 | V |

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 6)

|  | PARAMETER | MIN | TYP $\dagger$ |
| :--- | :--- | ---: | ---: |
| $t_{\text {valid }}$ | Mropagation delay time, low- to high-level output | UNIT |  |
| $t_{\text {invalid }}$ | Propagation delay time, high- to low-level output | 1 | $\mu \mathrm{~s}$ |
| $\mathrm{t}_{\mathrm{en}}$ | Supply enable time | 30 | $\mu \mathrm{~s}$ |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

## PARAMETER MEASUREMENT INFORMATION



NOTES: A. $\mathrm{C}_{\mathrm{L}}$ includes probe and jig capacitance.
B. The pulse generator has the following characteristics: $\mathrm{PRR}=250 \mathrm{kbit} / \mathrm{s}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, 50 \%$ duty cycle, $\mathrm{t}_{\mathrm{r}} \leq 10 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 10 \mathrm{~ns}$.

Figure 2. Driver Slew Rate


NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. The pulse generator has the following characteristics: $\mathrm{PRR}=250 \mathrm{kbit} / \mathrm{s}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, 50 \%$ duty cycle, $\mathrm{t}_{\mathrm{r}} \leq 10 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 10 \mathrm{~ns}$.

Figure 3. Driver Pulse Skew


NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. The pulse generator has the following characteristics: $Z_{O}=50 \Omega, 50 \%$ duty cycle, $\mathrm{t}_{\mathrm{r}} \leq 10 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 10 \mathrm{~ns}$.

Figure 4. Receiver Propagation Delay Times

## PARAMETER MEASUREMENT INFORMATION



NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. The pulse generator has the following characteristics: $Z_{O}=50 \Omega, 50 \%$ duty cycle, $\mathrm{t}_{\mathrm{r}} \leq 10 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 10 \mathrm{~ns}$.
C. $t_{P L Z}$ and $t_{P H Z}$ are the same as $t_{\text {dis }}$.
D. tPZL and tPZH are the same as ten.

Figure 5. Receiver Enable and Disable Times

## PARAMETER MEASUREMENT INFORMATION



$\dagger$ Auto-powerdown disables drivers and reduces supply current to $1 \mu \mathrm{~A}$.

NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. The pulse generator has the following characteristics: $\mathrm{PRR}=5 \mathrm{kbit} / \mathrm{s}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, 50 \%$ duty cycle, $\mathrm{t}_{\mathrm{r}} \leq 10 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 10 \mathrm{~ns}$.

Figure 6. $\overline{\text { INV }}$ Propagation Delay Times and Supply Enabling Time

APPLICATION INFORMATION

$\dagger$ C3 can be connected to $\mathrm{V}_{\mathrm{CC}}$ or GND.
NOTES: A. Resistor values shown are nominal.
B. Numbers in parentheses are for $B$ section.
$V_{C C}$ vs CAPACITOR VALUES

| $\mathrm{V}_{\text {CC }}$ | C 1 | C2, C3, and C4 |
| :---: | :---: | :---: |
| $3.3 \mathrm{~V} \pm 0.3 \mathrm{~V}$ | $0.22 \mu \mathrm{~F}$ | $0.22 \mu \mathrm{~F}$ |
| $5 \mathrm{~V} \pm 0.5 \mathrm{~V}$ | $0.047 \mu \mathrm{~F}$ | $0.33 \mu \mathrm{~F}$ |
| 3 V to 5.5 V | $0.22 \mu \mathrm{~F}$ | $1 \mu \mathrm{~F}$ |

Figure 7. Typical Operating Circuit and Capacitor Values

INSTRUMENTS

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead finish/ Ball material <br> (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN65C23243DGGR | LIFEBUY | TSSOP | DGG | 48 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | 65 C 23243 |  |
| SN65C23243DLR | LIFEBUY | SSOP | DL | 48 | 1000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | 65 C 23243 |  |
| SN75C23243CDGGR | PREVIEW | TSSOP | DGG | 48 | 2000 | TBD | Call TI | Call TI |  |  |  |
| SN75C23243CDLR | PREVIEW | SSOP | DL | 48 | 1000 | TBD | Call TI | Call TI |  |  |  |
| SN75C23243DGGR | LIFEBUY | TSSOP | DGG | 48 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | 75 C 23243 |  |
| SN75C23243DLR | LIFEBUY | SSOP | DL | 48 | 1000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | 75C23243 |  |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a " $\sim$ will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TeXAS
PACKAGE MATERIALS INFORMATION
INSTRUMENTS

TAPE AND REEL INFORMATION

*All dimensions are nominal

| Device | Package <br> Type | Package <br> Drawing | Pins | SPQ | Reel <br> (iameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> W1 $(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | B0 <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | W <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN65C23243DGGR | TSSOP | DGG | 48 | 2000 | 330.0 | 24.4 | 8.6 | 13.0 | 1.8 | 12.0 | 24.0 | Q1 |
| SN65C23243DLR | SSOP | DL | 48 | 1000 | 330.0 | 32.4 | 11.35 | 16.2 | 3.1 | 16.0 | 32.0 | Q1 |
| SN75C23243DGGR | TSSOP | DGG | 48 | 2000 | 330.0 | 24.4 | 8.6 | 13.0 | 1.8 | 12.0 | 24.0 | Q1 |
| SN75C23243DLR | SSOP | DL | 48 | 1000 | 330.0 | 32.4 | 11.35 | 16.2 | 3.1 | 16.0 | 32.0 | Q1 |

PACKAGE MATERIALS INFORMATION

*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN65C23243DGGR | TSSOP | DGG | 48 | 2000 | 367.0 | 367.0 | 45.0 |
| SN65C23243DLR | SSOP | DL | 48 | 1000 | 367.0 | 367.0 | 55.0 |
| SN75C23243DGGR | TSSOP | DGG | 48 | 2000 | 367.0 | 367.0 | 45.0 |
| SN75C23243DLR | SSOP | DL | 48 | 1000 | 367.0 | 367.0 | 55.0 |

DL (R-PDSO-G48)


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed $0.006(0,15)$.
D. Falls within JEDEC MO-118


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. Reference JEDEC registration MO-153.


SOLDER MASK DEFINED

SOLDER MASK DETAILS

NOTES: (continued)
5. Publication IPC-7351 may have alternate designs.
6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.


SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:6X

NOTES: (continued)
7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

48 PINS SHOWN


NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold protrusion not to exceed 0,15.
D. Falls within JEDEC MO-153

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[^0]:    $\ddagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
    NOTE 4: Test conditions are $\mathrm{C} 1-\mathrm{C} 4=0.22 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V} ; \mathrm{C} 1=0.047 \mu \mathrm{~F}, \mathrm{C} 2-\mathrm{C} 4=0.33 \mu \mathrm{~F}$ at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V} \pm 0.5 \mathrm{~V}$.

